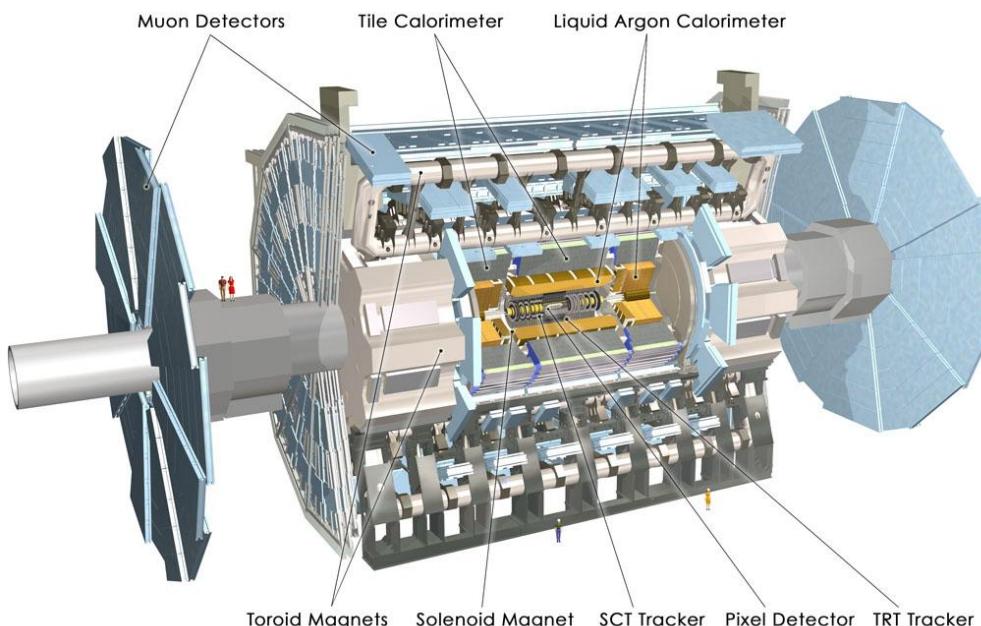

Top quark cross section measurement @ ATLAS with dilepton final state

奥村恭幸
(OKUMURA, Yasuyuki)

Nagoya University,
High energy particle physics (N) group

LHC & ATLAS

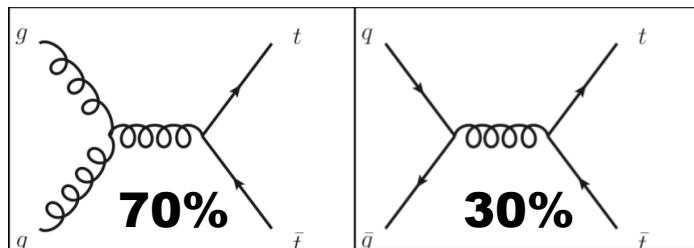
- LHC experiment
 - 陽子-陽子衝突実験
 - 重心系 7 TeV.
 - 2010 年より本格稼働 !



- ATLAS detectors.
 - 飛跡検出器
 - カロリメータ (EM/H-Cal)
 - ミューオン検出器

トップクォーク @ LHC

- 標準模型粒子の中で最大質量をもつ素粒子.
 - $172.0 \pm 0.9 \pm 1.3 \text{ GeV}/c^2$.
- トップクォーク生成 @ LHC
 - NNLO QCD Prediction = 164.6 pb.
 - Gluon-gluon fusion (70%).
 - Quark-quark annihilation (30%).



- トップクォーク対生成断面積の測定、崩壊分岐比の測定
 - 標準模型を超えた物理への感度
 - $H^{+/-}$ production in t quark decay.
 - $qq \rightarrow Z' \rightarrow tt$ production.
 - 標準模型の良いテスト (摂動 QCD の精密検証)

ダイレプトン終状態を用いた解析

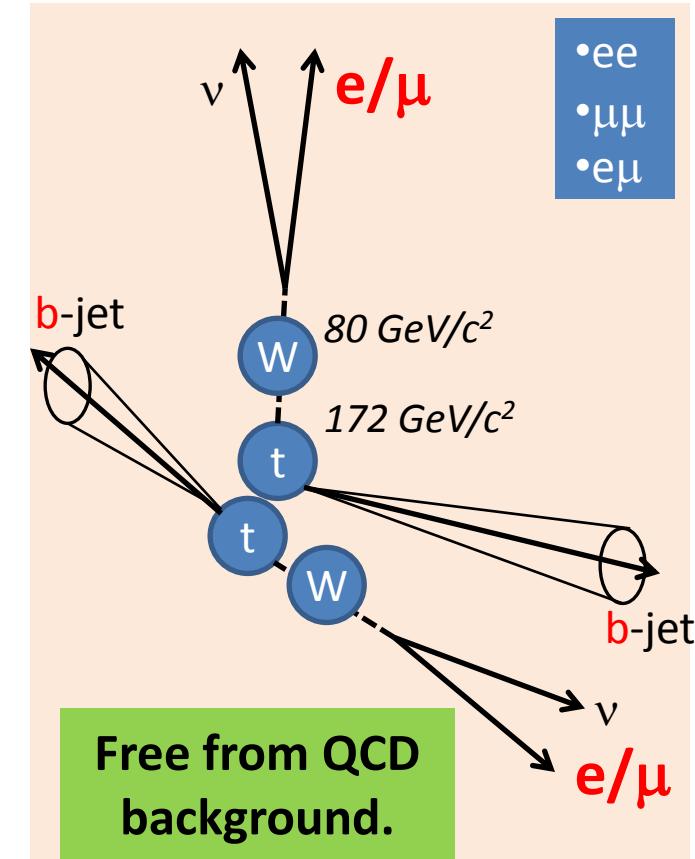
- 候補事象の選別.
 - 2本のレプトンをタグに信号を検出.
 - 背景事象との分離のための Veto
 - Z 不变質量を作るダイレプトン事象
 - 横運動量のアンバランス (Missing ET) が小さい事象
 - ジェットが二本以上ない事象

- 105 Observed events (2010 data)**
 - ee **16**, $\mu\mu$ **31**, $e\mu$ **58** events.

- 生成断面積の測定

$$\sigma_{tt} \times BR(ll) = \frac{N_{\text{observed}} - N_{\text{background}}}{\mathcal{A}} \times \frac{1}{\mathcal{L}}$$

- 観測事象数. 背景事象数. 信号事象に対するアクセプタンス. ルミノシティを正確に把握して、評価.



ダイレプトン tt 事象の候補

High momentum
Muon track
(Muon detector)

High Energy
jet 1 (Calorimeter)

High Energy
jet 2 (Calorimeter)

High Energy Electron
(EM-Calorimeter)

e μ 候補

Missing ET
(Imbalance of total
transverse energy)



Run Number: 160958, Event Number: 9038972

Date: 2010-08-08 11:01:12 BST

信号事象に対するアクセプタンス評価

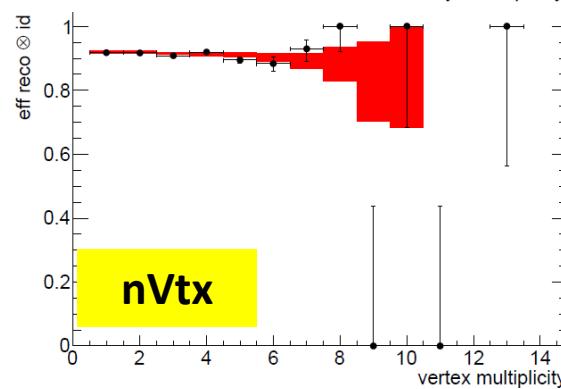
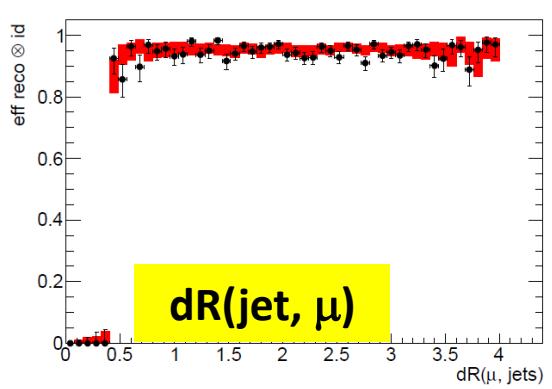
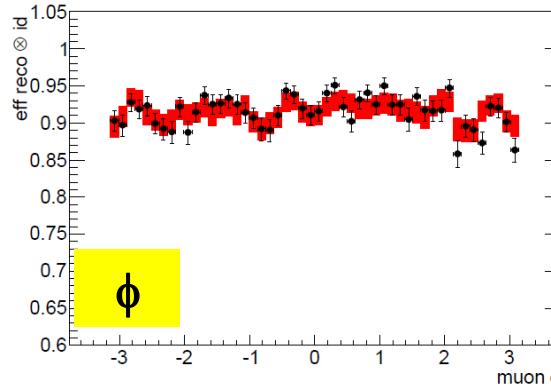
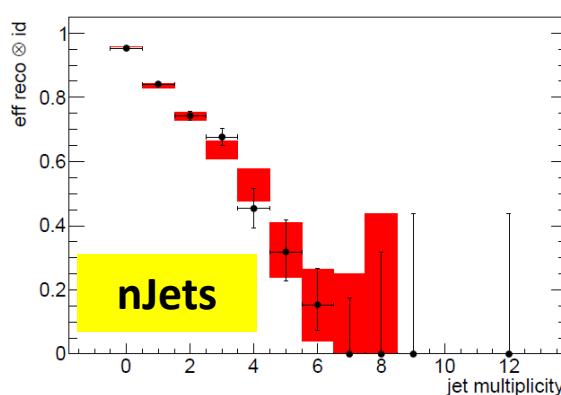
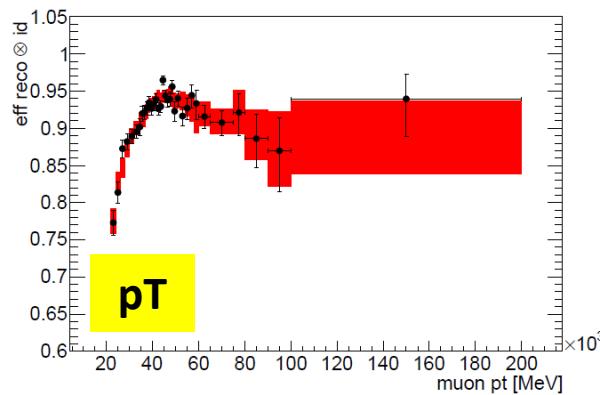
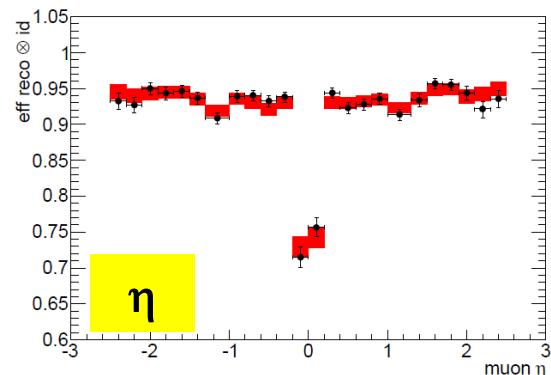
- 検出器の性能を反映したシミュレーションを用いて評価
 - 終状態粒子の運動学的特徴をシミュレーションを用いて評価
 - 検出器性能を実機データから評価。
 - 検出器の検出効率、運動量・エネルギー測定のスケール分解能
- 評価の安定性の確認
 - 検出器の性能評価における不定性
 - シミュレーションのモデリングに対する不定性.

Channel	Acceptance estimation.
Ee	11.5±1.4%
$\mu\mu$	20.5±1.6%
e μ	24.3±1.9%

アクセプタンス評価の詳細

- レプトンの検出効率 & トリガー効率
 - Zボソンプロセスを利用して評価.

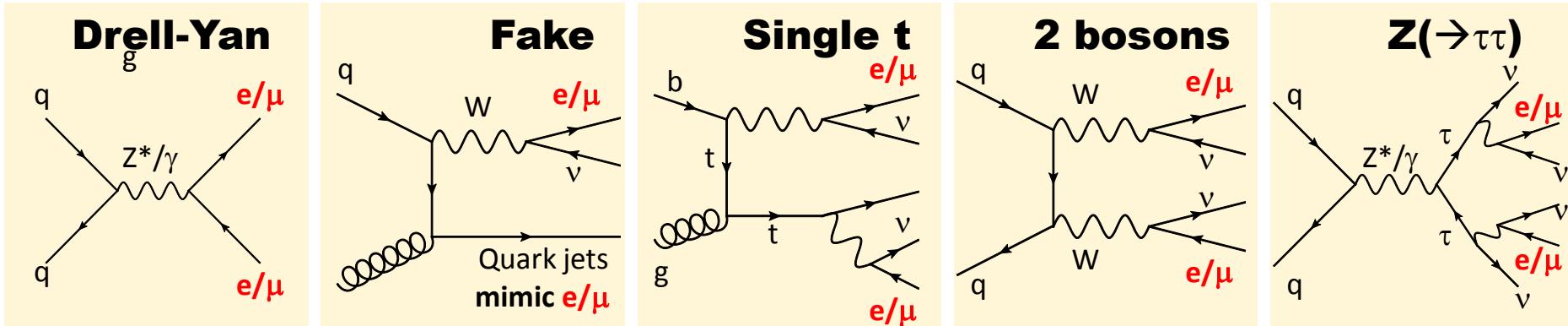
● 実測値, ■ シミュレーション



- モンテカルロ・シミュレーションの記述の妥当性を証明.
- 位相空間、事象の”混み具合”によらず、正確に記述 (top 事象でも OK)
- 検出器実機の性能を正確に把握して、高い確度でのアクセプタンス評価を実現

背景事象数の評価

- ダイレプトン解析における背景事象の候補



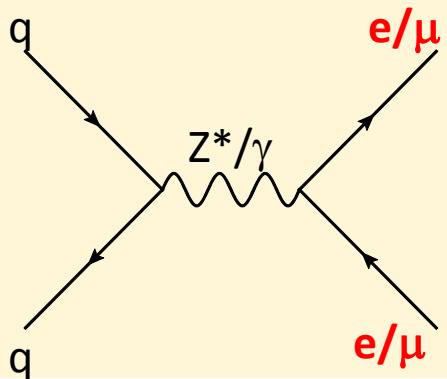
Channel	DY	Fake	Single top	WW/WZ/ZZ	$Z(\rightarrow \tau\tau)$
ee	1.1 ± 0.5	0.8 ± 0.8	0.6 ± 0.1	0.5 ± 0.2	0.5 ± 0.3
$\mu\mu$	3.6 ± 1.8	0.5 ± 0.6	1.3 ± 0.2	0.9 ± 0.3	1.1 ± 0.6
eμ	-	3.0 ± 2.6	2.5 ± 0.4	2.1 ± 0.8	3.2 ± 1.5

- 背景事象数の評価結果

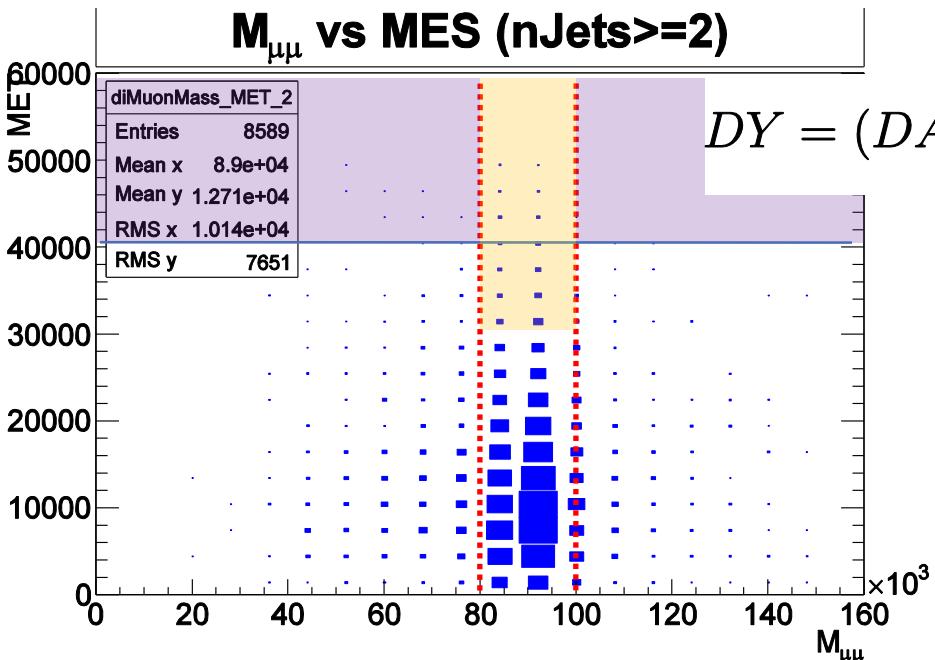
- ee : **3.5 ± 1.1 events**
- $\mu\mu$: **7.4 ± 2.0 events**
- e μ : **10.8 ± 3.7 events**

背景事象数評価の詳細 (1) DY

Drell-Yan



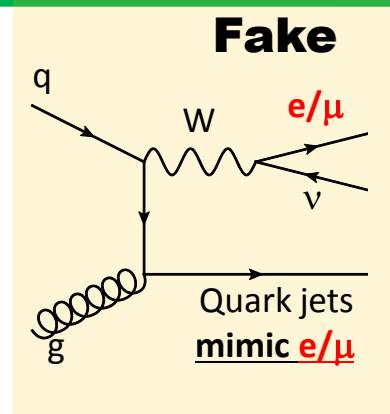
- MET の “mis-measurement rate” をデータから評価。
 - コントロール領域を定義
 - $n\text{Jets} \geq 2$, Inside Z mass, MET>30GeV.
 - Z*/g purity $\approx 90\%$
 - コントロール領域の観測事象数を信号領域へ外挿して評価



Channel	Expectation
ee	1.1 ± 0.5
$\mu\mu$	3.6 ± 1.8

Background estimation details (2)

- レプトンの “**mis-particle-ID rate**” をデータから評価。
 - QCD 2jets 事象を用いて、jet が tight な particle ID を通過する確率を測定. (= fake rate; f)

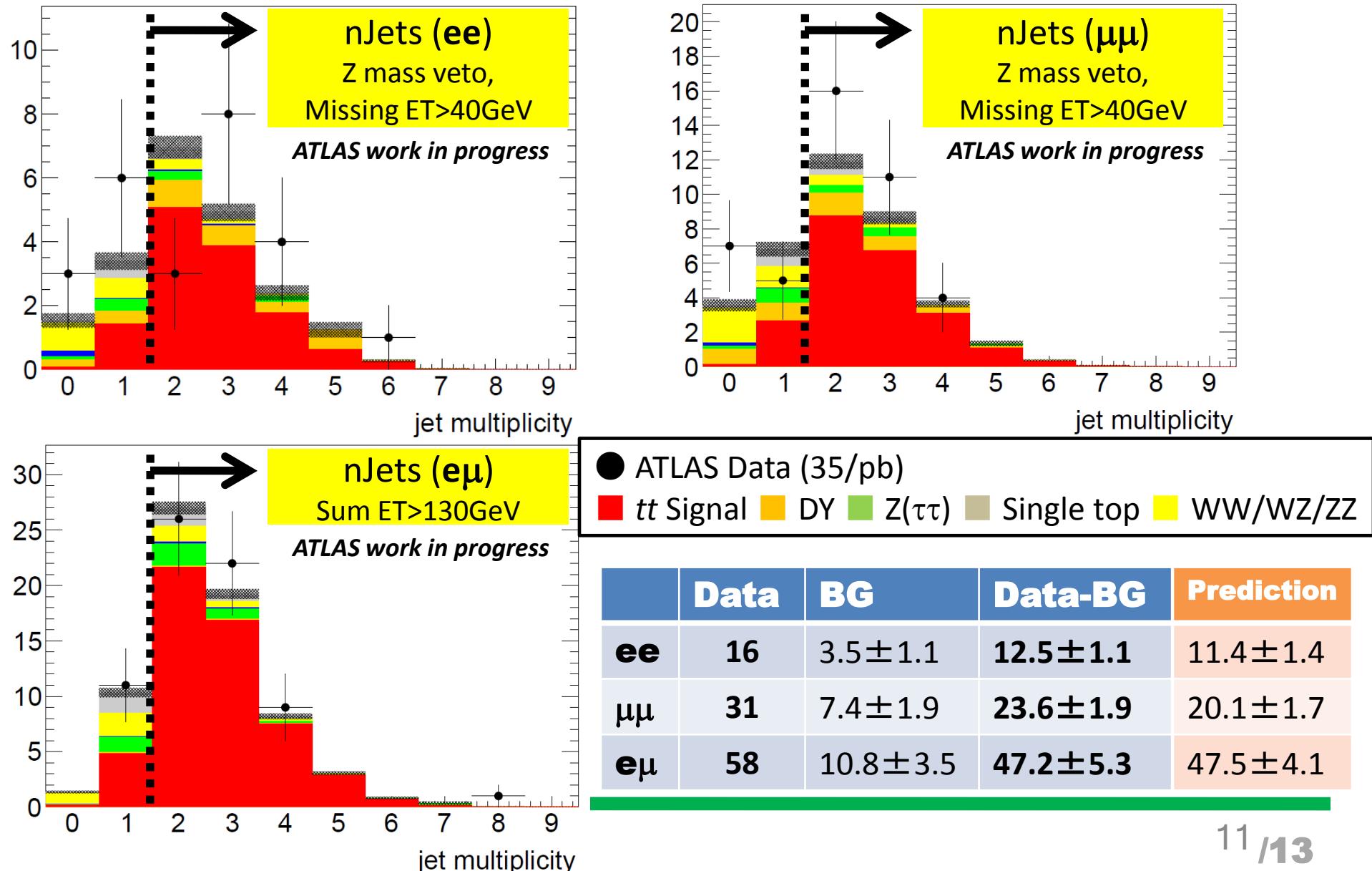


$$\begin{bmatrix} N_{TT} \\ N_{TL} \\ N_{LT} \\ N_{LL} \end{bmatrix} = \begin{bmatrix} rr & rf & fr & ff \\ r(1-r) & r(1-f) & f(1-r) & f(1-f) \\ (1-r)r & (1-r)f & (1-f)r & (1-f)f \\ (1-r)(1-r) & (1-r)(1-f) & (1-f)(1-r) & (1-f)(1-f) \end{bmatrix} \begin{bmatrix} N_{RR} \\ N_{RF} \\ N_{FR} \\ N_{FF} \end{bmatrix}$$

- 連立方程式を解き、選別される事象数を評価
 - $rf \times N_{FR} + fr \times N_{RF}$, (W+jets.) + $ff \times N_{FF}$ (QCD)

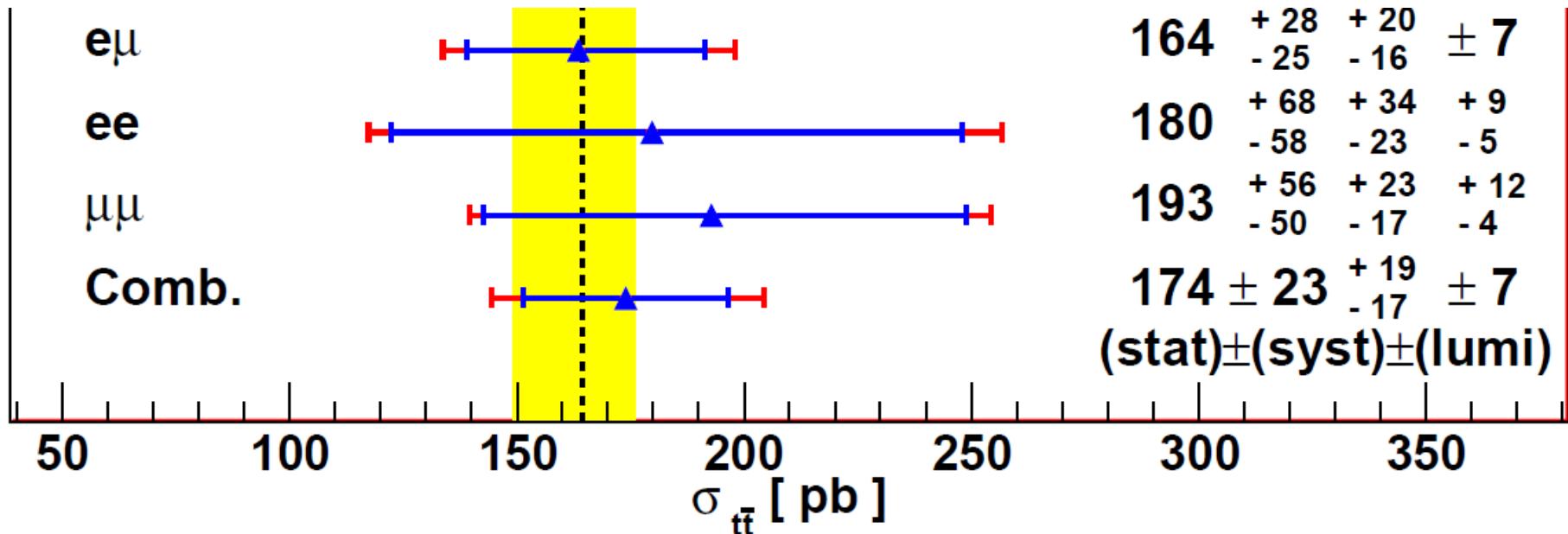
	ee	μμ
Expectation	0.8 ± 0.8	0.5 ± 0.6

検出事象数の評価



生成断面積の測定結果

- Results from individual channel analysis.



- 高い精度での測定を実現.
 - 3 チャンネルコンビン時の測定の Significance = 5.7σ
- NNLO の計算 (164.6pb) に一致

まとめ

- トップ対生成断面積の測定 @ LHC-ATLAS
 - 検出器の応答を精密に理解.
 - 7 TeV の陽子・陽子衝突における初の精密測定 significance 5.7 σ .

combined	174.0	^{*1}	^{*2}	^{*3}
		+22.6	+19.1	+7.0
		-22.6	-17.4	-7.0

*1 statistics uncertainties, *2 systematic uncertainties, *3 luminosity uncertainties

pQCD の計算と 5.7σ の有意さで、一致することを証明。

BACK UP SLIDES

Event display of dilepton tt candidate

High momentum
Muon track
(Muon detector)

High Energy
jet 1 (Calorimeter)

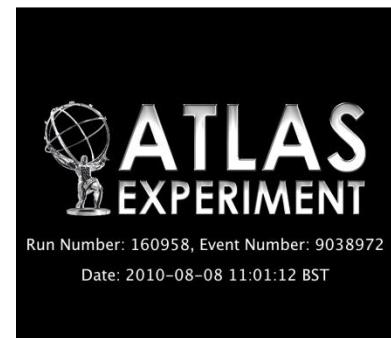
High Energy
jet 2 (Calorimeter)

High Energy Electron
(EM-Calorimeter)

Top quark pair
production
candidate event

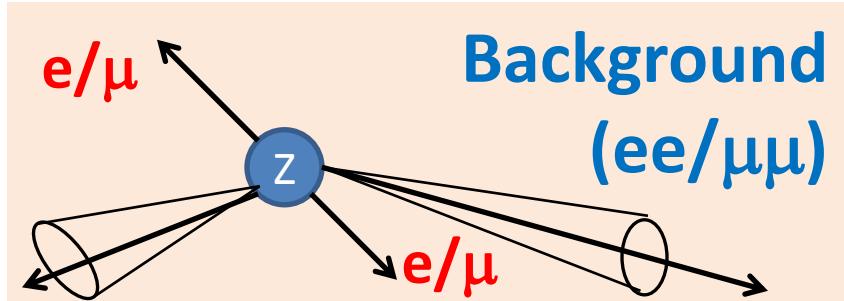
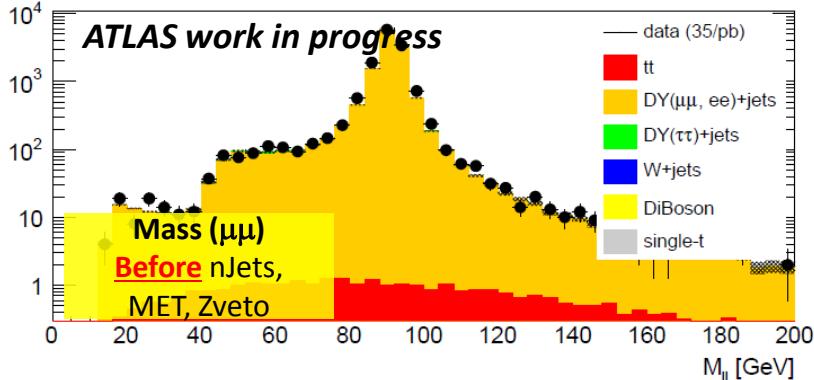
(e+ μ)

Missing ET
(Imbalance of total
transverse energy)



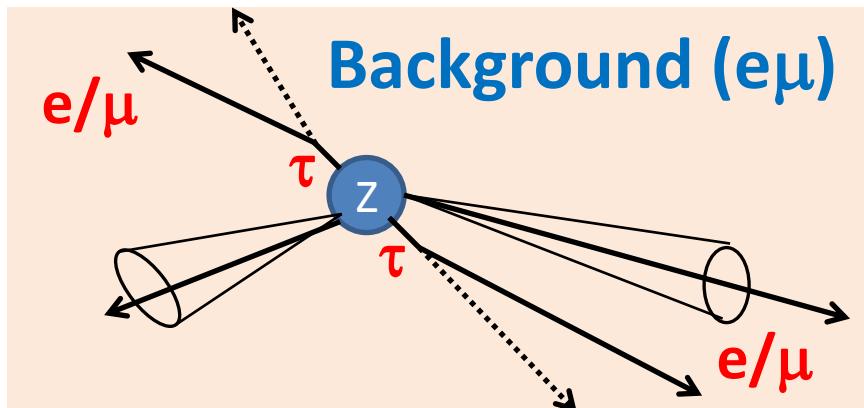
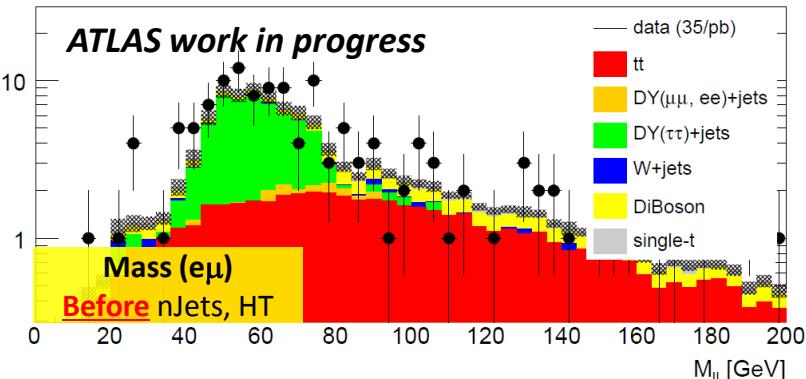
Background physics process

- ee/ $\mu\mu$ channel



- Z (DY) physics process dominates. $\sigma(Z \rightarrow \mu\mu/ee)/\sigma(tt \rightarrow \mu\mu/ee) = 500$
- Tight cut is required to reject DY .

- e μ channel

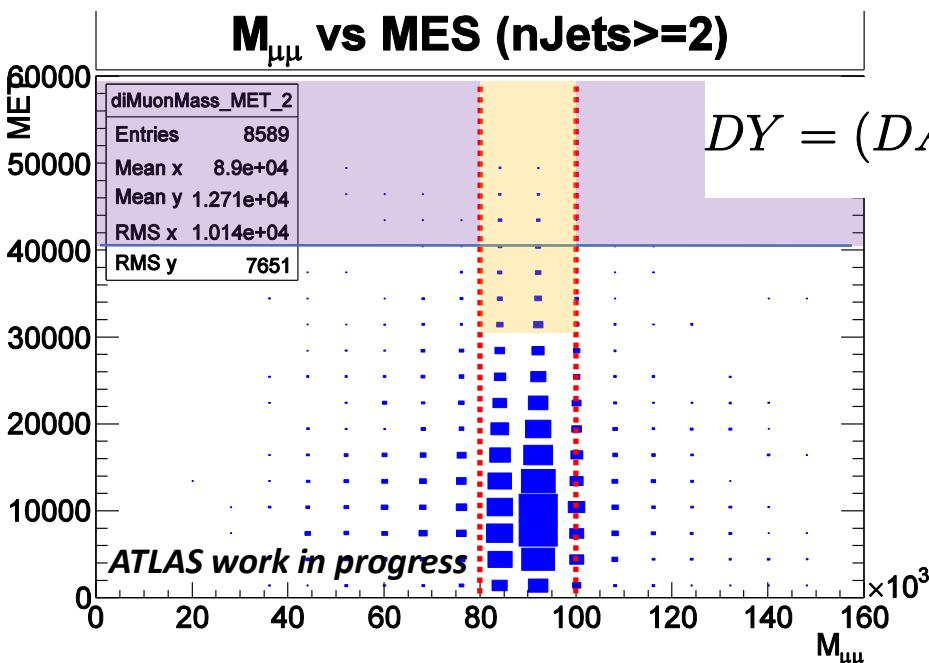


- Background free. ($Z \rightarrow \tau\tau$ physics process is the largest BG source.)

Background estimation

Drell - Yan

- Estimate MET mismeasurement rate, using control region.
 - Control region is defined in Z mass window (Z^*/g purity $\approx 90\%$) with $n\text{Jets} \geq 2$, Inside Z mass, $\text{MET} > 30\text{GeV}$.
- Estimate the DY contamination in SR.



$$DY = (DATA(CR) - MC_{\text{background}}) \times \frac{MC(SR)}{MC(CR)}$$

Channel	Expectation
ee	1.1 ± 0.5
μμ	3.6 ± 1.8

Background estimation Fake lepton

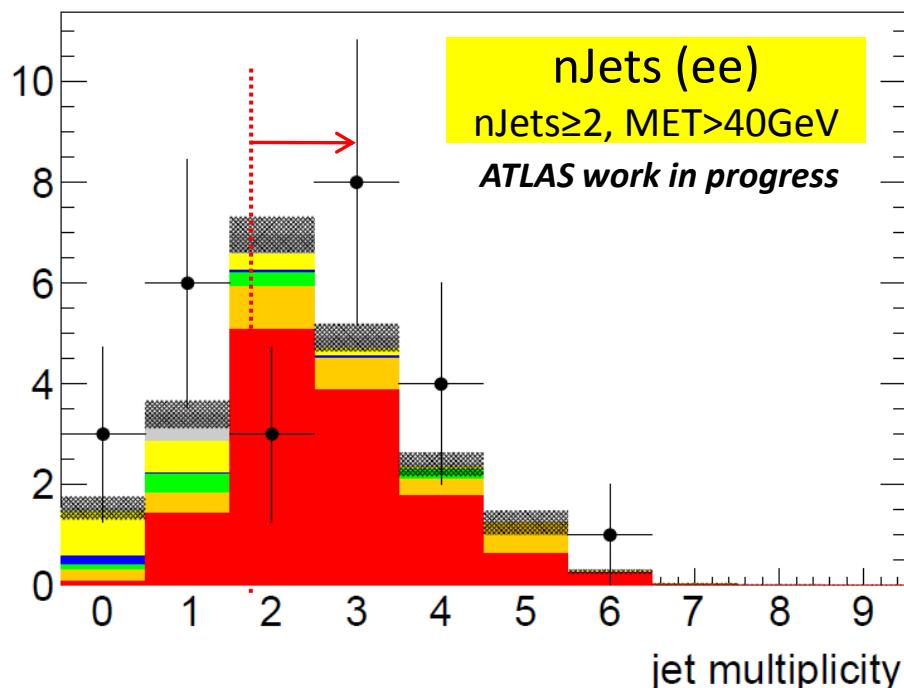
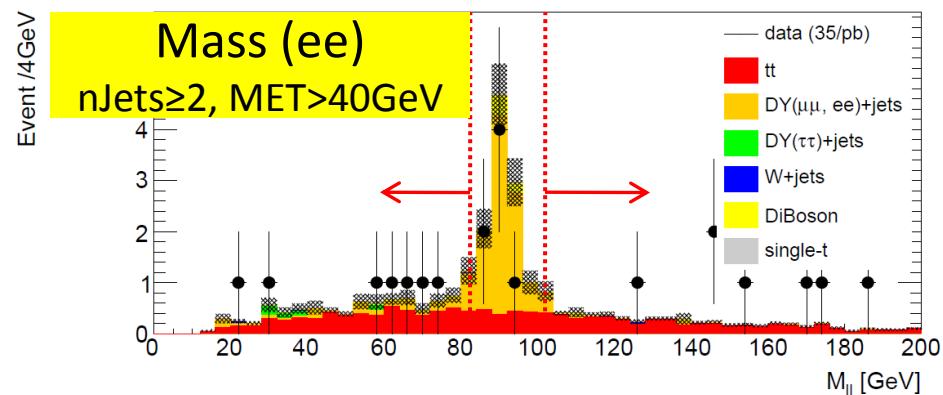
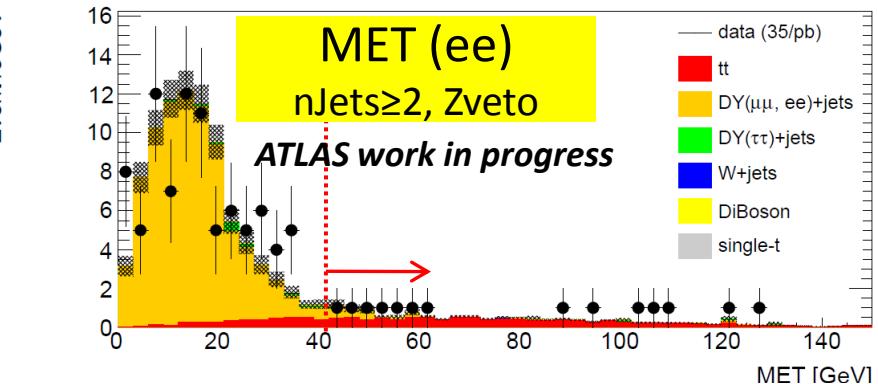
- Measure detection rate for real & fake lepton.
 - $Z(\rightarrow ee/\mu\mu)$, QCD 2jets events are used to estimate detection rate for real & fake leptons.

$$\begin{bmatrix} N_{TT} \\ N_{TL} \\ N_{LT} \\ N_{LL} \end{bmatrix} = \begin{bmatrix} rr & rf & fr & ff \\ r(1-r) & r(1-f) & f(1-r) & f(1-f) \\ (1-r)r & (1-r)f & (1-f)r & (1-f)f \\ (1-r)(1-r) & (1-r)(1-f) & (1-f)(1-r) & (1-f)(1-f) \end{bmatrix} \begin{bmatrix} N_{RR} \\ N_{RF} \\ N_{FR} \\ N_{FF} \end{bmatrix}$$

- Solve the equations, and number of events including fakes (N_{FR} , N_{RF} , N_{FF}).
 - N_{FR} , N_{RF} , are corresponding to $W+jets$.
 - N_{FF} , are corresponding to QCD.

	ee	$\mu\mu$
Expectation	0.8 ± 0.8	0.5 ± 0.6

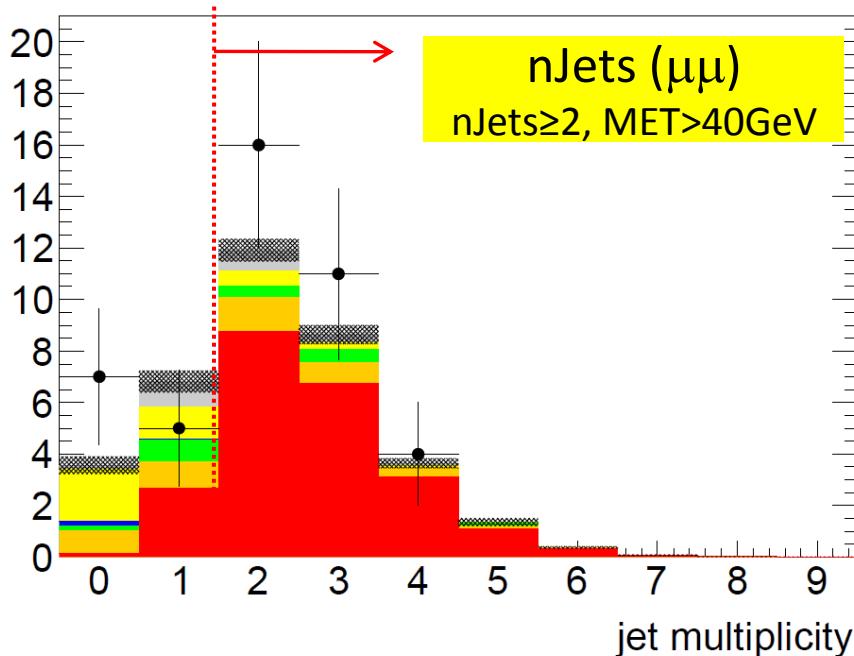
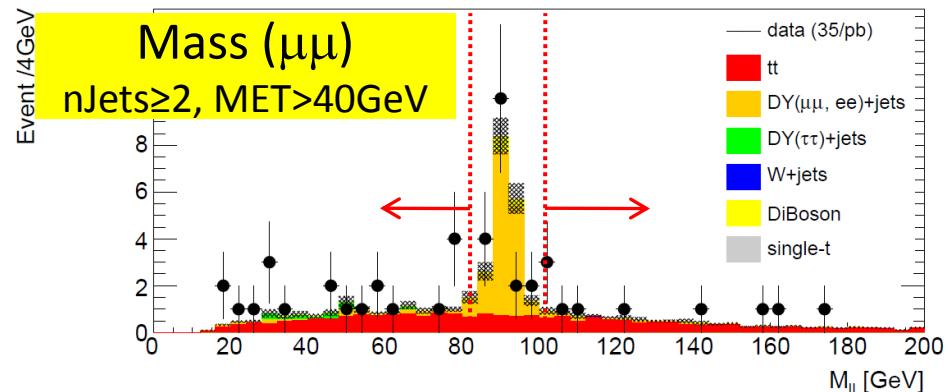
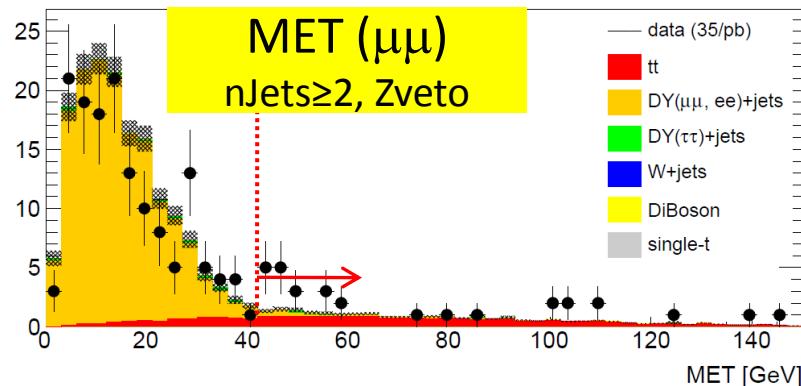
Event yield (ee)



- **16 events observed.**
- 14.9 ± 1.7 events expected.
 - 11.4 ± 1.4 signals.
 - 3.5 ± 1.1 backgrounds.

Event yield ($\mu\mu$)

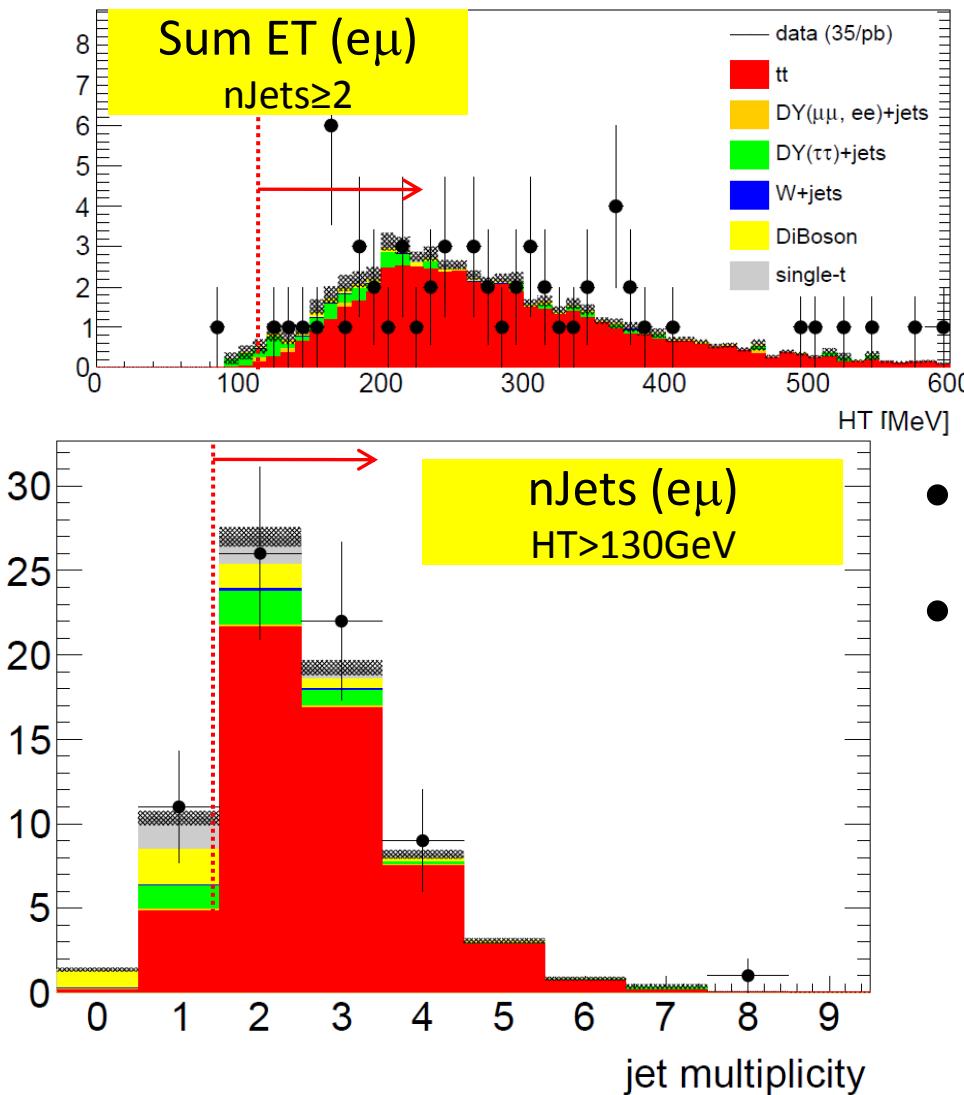
Event /3GeV



- **31** events observed.
- 27.5 ± 2.5 events expected.
 - 20.1 ± 1.7 signals.
 - 7.4 ± 1.7 backgrounds.

Event yield ($e\mu$)

Event



- **58 events observed.**
- **58.3 ± 5.3 events expected.**
 - 47.5 ± 4.1 signals.
 - 10.8 ± 3.5 backgrounds.

Event Yield summary

	ee	$\mu\mu$	$e\mu$
Z+jets (DD)	1.1 ± 0.5	$3.6^{+1.8}_{-1.2}$	-
Z($\rightarrow \tau\tau$)+jets (MC)	0.5 ± 0.3	1.1 ± 0.6	$3.2^{+1.5}_{-1.4}$
Non-Z leptons (DD)	0.8 ± 0.8	0.5 ± 0.6	3.0 ± 2.6
Single top (MC)	0.6 ± 0.1	1.3 ± 0.2	2.5 ± 0.4
Dibosons (MC)	0.5 ± 0.1	0.9 ± 0.2	$2.1^{+0.5}_{-0.3}$
Total (non $t\bar{t}$)	$3.5^{+1.1}_{-1.0}$	$7.4^{+1.9}_{-1.6}$	$10.8^{+3.5}_{-3.2}$
$t\bar{t}$ (MC)	$11.4^{+1.4}_{-1.2}$	$20.1^{+1.6}_{-1.7}$	$47.5^{+3.9}_{-4.1}$
Total expected	$14.9^{+1.7}_{-1.6}$	$27.5^{+2.5}_{-2.4}$	$58.3^{+5.3}_{-5.2}$
Observed	16	31	58

Background estimation

- **Categorization of background**

- (1) $Z^*/\gamma(ee), Z^*/\gamma(\mu\mu)$ **Drell - Yan**
 - Pass event selection due to mis-measurement of MET.
- (2) $W(e\nu)+\text{jets}, W(\mu\nu)+\text{jets}$ **Fake lepton**
 - Pass event selection due to mis-particle identification.
(jets mimic e/ μ)
- (3) $Z(\tau\tau) + \text{jets}, WW + \text{jets}, WZ + \text{jets}, \text{Single top}$
 - Similar event topology with 2 leptons, MET, & jets.

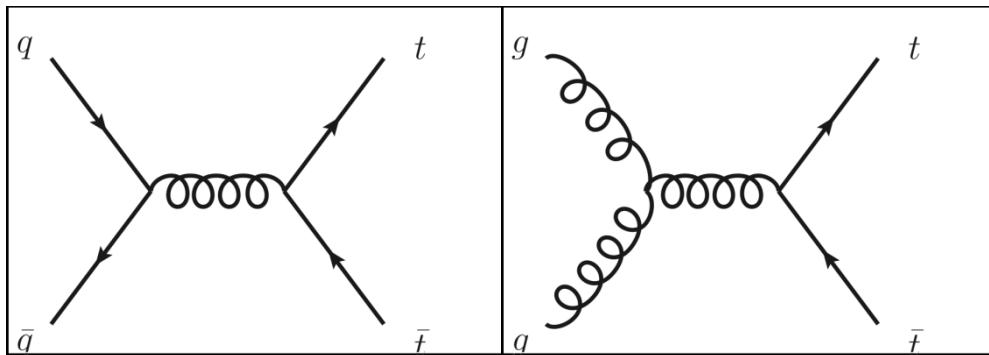
SM process

- **Strategy of estimation**

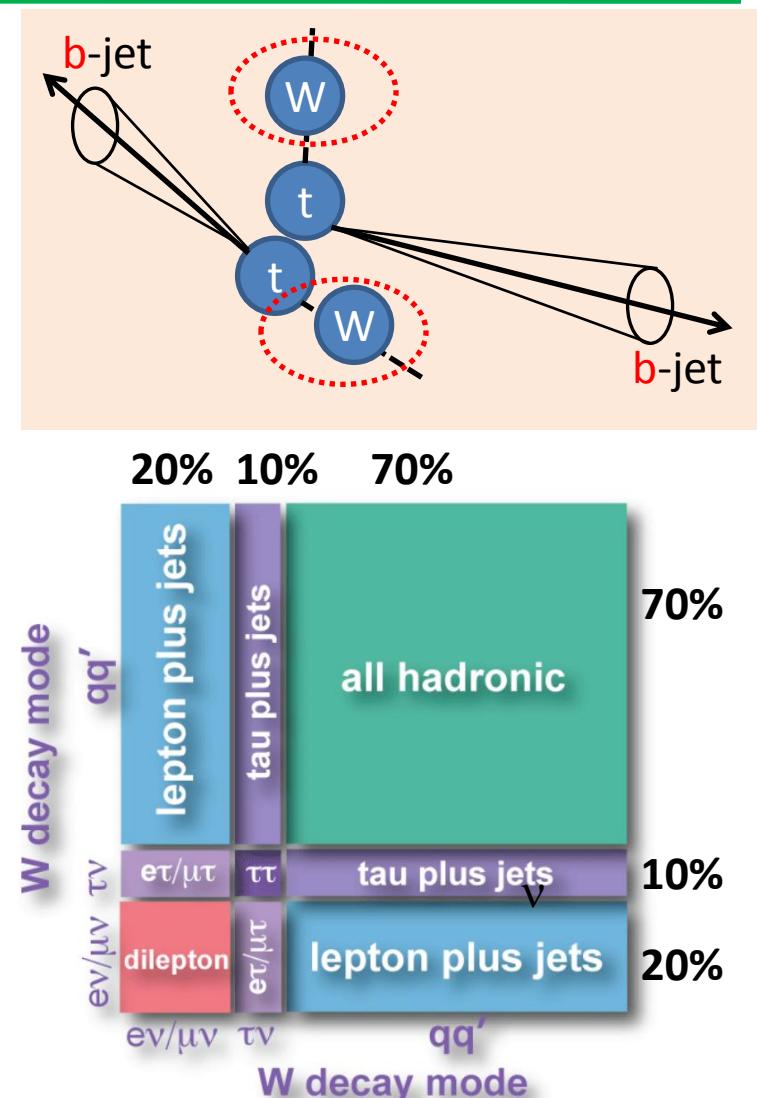
- (1) & (2) are estimated from **real detector response**.
 - Since it is difficult to reproduce mis-measurement in simulation.
- (3) are estimated from MC prediction.

Top quark pair production & decay

- Top quark pair production.
 - **160 pb** (NNLO) @ 7TeV
 - $gg \rightarrow tt$ (70%), $qq \rightarrow tt$ (30%)



- Final state of tt
 - l + jets : BR = 28%
 - **di lepton** : **BR = 4%**
 - all jets : BR = 49%
 - tau : BR = 19%

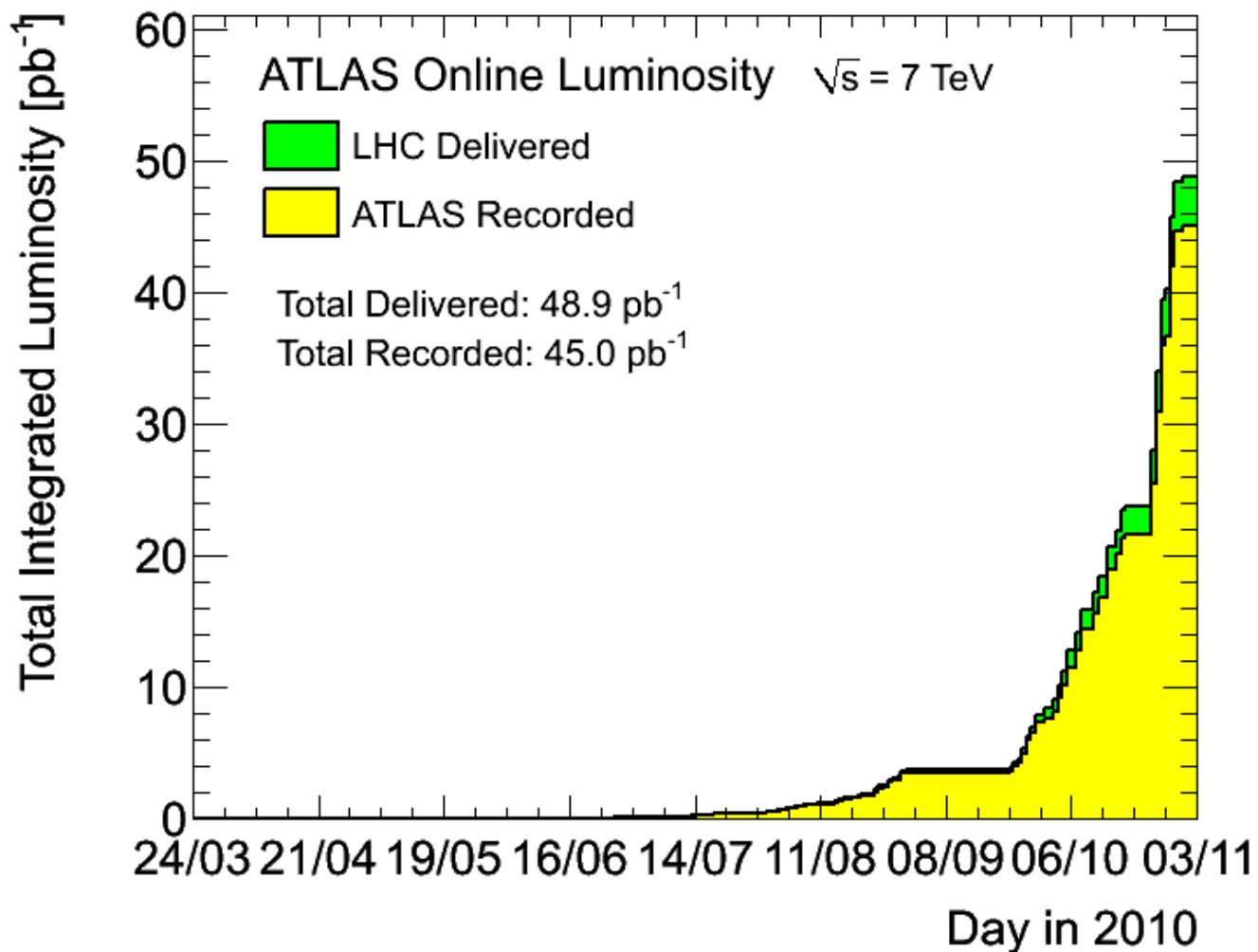


Cross section measurement

$$\sigma_{tt} \times BR(\mu\mu) = \frac{N_{\text{observed}} - N_{\text{background}}}{\mathcal{A}} \times \frac{1}{\mathcal{L}}$$

- Collect & count tt event candidate. (N_{observed})
- Estimate background. ($N_{\text{background}}$)
- Evaluate acceptance & the stability. (\mathcal{A})
 - Detector performance.
 - Event modeling.
- Measure luminosity (\mathcal{L})

Luminosity



Systematic error estimation

	Background	Acceptance	Cross Section
	3.5	0.115	180.0
	Δ Background %	Δ Acceptance %	Δ Cross Section %
Luminosity	+1.2/-1.2	-	-3.4/+3.7
Data Stat	+10.9/-8.7	-	+40.9/-31.9
MC Stat	± 8.8	± 2.2	± 3.4
Pile-up	± 0.4	± 0.3	± 0.2
Fake	± 22.6	-	± 6.4
DD Method	± 8.7	-	± 2.2
MC x-sec	+6.9/-6.4	-	-2.1/+2.0
JES	+4.8/-5.9	+7.6/-5.5	-8.3/+7.6
JER	± 6.6	± 2.6	± 0.7
JEF	± 0.2	± 1.3	± 1.3
Mu ID SF	-	-	-
Mu Trig SF	-	-	-
El ID SF	+2.1/-2.1	+5.2/-5.2	-5.5/+6.1
El Trig SF	+0.4/-0.4	+1.0/-1.0	-1.1/+1.1
Mu ES	-	-	-
Mu ER (MS)	-	-	-
Mu ER (ID)	-	-	-
El ES	+0.6/+0.6	+0.5/-0.6	-0.6/+0.4
El Resolution	+0.3/-0.1	-0.0/+0.1	-0.1/-0.1
P.Shower	-	± 4.4	± 4.4
Generator	-	± 1.0	± 1.0
ISR	-	± 0.1	± 0.1
FSR	-	± 3.1	± 3.1
PDF	-	± 2.5	± 2.5
Syst. total	+28.0/-28.1	+11.6/-10.4	+14.0/-14.2
Cross Section (observed)	$180.0^{+73.7}_{-57.4} {}^{+25.2}_{-25.5} {}^{+6.6}_{-6.2}$ pb		

	single top	diboson	Z $\tau\tau$
Yield	0.6	0.5	0.5
Uncertainty(%)			
Lumi	± 3.2	± 3.2	± 3.2
JES	+20.1/-11.8	+24.8/-14.2	+20.9/-20.6
JER	± 1.3	± 0.7	± 20.6
JEF	± 2.2	± 1.6	± 0.0
El ID SF	+5.2/-5.2	+5.3/-5.3	+5.5/-5.5
El Trig SF	+1.0/-1.0	+1.0/-1.0	+1.0/-1.0
Mu ID SF	-	-	-
Mu Trig SF	-	-	-
MC xsec	+10.0/-10.0	+5.0/-5.0	+39.6/-39.6
MC Stat	± 5.9	± 5.1	± 44.8
Pile-up	± 2.9	± 3.9	± 5.7
El ES	+0.3/-0.6	-0.8/-1.5	+0.0/+0.0
El ER	-0.6/+0.6	-0.6/-1.0	+0.0/+0.0
Mu ES	-	-	-
Mu ER (MS)	-	-	-
Mu ER (ID)	-	-	-
total (syst + lumi)	+24.3/-18.1	+26.8/-17.7	+67.2/-67.1

ee

Systematic error estimation

	Background	Acceptance	Cross Section
	7.4	0.205	193.2
	Δ Background %	Δ Acceptance %	Δ Cross Section %
Luminosity	+1.3/-1.3	-	-3.5/+3.7
Data Stat	+7.0/-6.3	-	+28.2/-23.5
MC Stat	± 8.9	± 1.6	± 3.2
Pile-up	± 1.8	± 0.9	± 0.4
Fake	± 7.7	-	± 2.4
DD Method.	± 10.8	-	± 0.9
MC x-sec	+9.4/-11.6	-	-2.9/+3.5
JES	+5.9/+14.2	+3.2/-4.1	-4.9/-0.3
JER	± 6.4	± 1.0	± 1.0
JEF	± 0.1	± 1.7	± 1.7
Mu ID SF	+0.3/-0.3	+0.7/-0.7	-0.8/+0.8
Mu Trig SF	+0.2/-0.2	+0.3/-0.3	-0.4/+0.4
Ele ID SF	-	-	-
Ele Trig SF	-	-	-
Mu ES	+0.2/+0.4	+0.2/-0.2	-0.2/+0.1
Mu ER (MS)	+1.5/-2.0	-0.0/-0.0	-0.4/+0.6
Mu ER (ID)	+5.5/-2.9	+0.1/+0.1	-1.9/+0.8
El ES	+0.0/+0.0	+0.0/+0.0	+0.0/+0.0
El ER	+0.0/+0.0	+0.0/+0.0	+0.0/+0.0
P.Shower	-	± 4.4	± 4.4
Generator	-	± 0.7	± 0.7
ISR	-	± 0.9	± 0.9
FSR	-	± 2.1	± 2.1
PDF	-	± 1.9	± 1.9
Syst. total	+25.0/-21.1	+6.8/-7.3	+8.0/-9.3
Cross Section (observed)	$193.2^{+54.4}_{-45.5} {}^{+15.5}_{-17.9} {}^{+7.2}_{-6.7}$ pb		

	single top	diboson		Z $\tau\tau$
	Yield	1.3	0.9	1.1
	Uncertainty(%)			
Lumi	± 3.2	± 3.2	± 3.2	± 3.2
JES	+10.0/-9.3	+18.9/-15.7	+24.5/+0.0	
JER	± 2.5	± 2.8	± 23.7	
JEF	± 2.6	± 2.3	± 0.0	
El ID SF	-	-	-	
El Trig SF	-	-	-	
Mu ID SF	+0.7/-0.7	+0.7/-0.7	+0.7/-0.7	
Mu Trig SF	+0.3/-0.3	+0.3/-0.3	+0.3/-0.3	
MC x-sec	+10.0/-10.0	+5.0/-5.0	+33.3/-33.3	
MC Stat	± 4.2	± 3.7	± 27.9	
Pile-up	± 2.1	± 5.0	± 9.3	
El ES	-	-	-	
El ER	-	-	-	
Mu ES	+0.3/-0.2	+1.0/+0.0	+0.0/+0.0	
Mu ER (MS)	+0.5/-0.2	+1.1/-0.0	+0.0/+0.0	
Mu ER (ID)	+0.2/-0.0	+0.6/+0.3	+0.0/+0.0	
total (syst + lumi)	+15.7/-15.2	+21.2/-18.3	+56.1/-50.5	

$\mu\mu$

Systematic error estimation

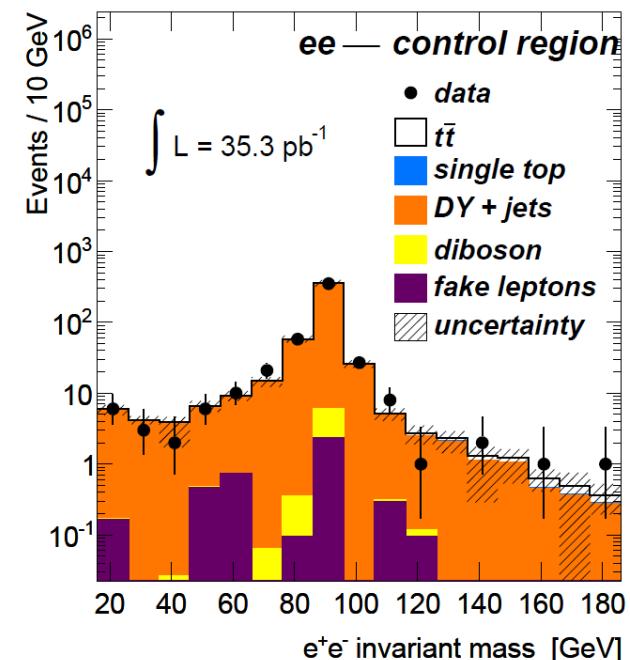
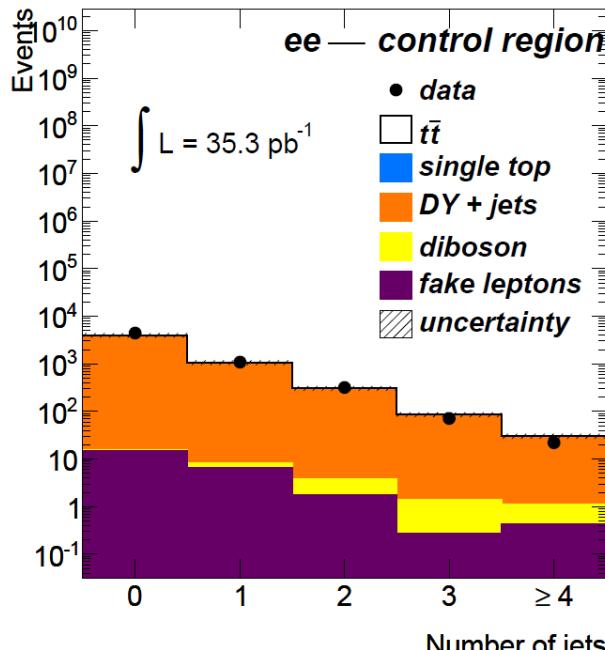
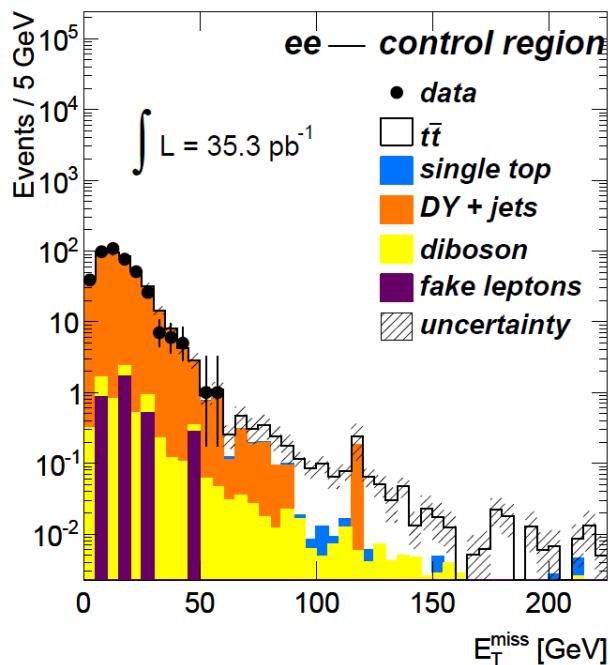
	Background	Acceptance	Cross Section
	10.8	0.243	163.6
	Δ Background %	Δ Acceptance %	Δ Cross Section %
Luminosity	+2.3/-2.3	-	-3.6/+3.9
Data Stat	-	-	+18.3/-16.1
MC Stat	± 5.1	± 1.1	± 1.6
Pile-up	± 5.0	± 0.6	± 1.7
Fake	± 23.9	-	± 5.5
DD Method (DY)	-	-	-
MC x-sec	+13.7/-13.7	-	-3.1/+3.1
JES	+14.3/-6.7	+1.9/-2.8	-5.1/+4.5
JER	± 1.2	± 1.3	± 1.0
JEF	± 2.5	± 1.7	± 2.3
Mu ID SF	+0.3/-0.3	+0.4/-0.4	-0.4/+0.4
Mu Trig SF	+0.0/-0.0	+0.0/-0.0	-0.0/+0.0
El ID SF	+2.7/-2.7	+3.7/-3.7	-4.1/+4.5
El Trig SF	+0.1/-0.1	+0.1/-0.1	-0.1/+0.1
Mu ES	+0.8/+0.0	+0.1/-0.1	-0.3/+0.1
Mu ER (MS)	+0.0/+0.8	-0.0/-0.0	+0.0/-0.2
Mu ER (ID)	-0.0/+0.1	-0.0/-0.0	+0.0/+0.0
El ES	+0.1/-0.2	+0.1/-0.1	-0.1/+0.2
El ER	-0.0/-0.0	+0.0/+0.0	-0.0/-0.0
P.Shower	-	± 5.2	± 5.2
Generator	-	± 1.2	± 1.2
ISR	-	± 1.2	± 1.2
FSR	-	± 1.1	± 1.1
PDF	-	± 2.2	± 2.2
Syst. total	+32.2/-29.6	+7.7/-8.0	+11.3/-11.4
Cross Section	$163.6^{+30.0}_{-26.3} {}^{+18.5}_{-18.7} {}^{+6.3}_{-5.9}$ pb		

	single top	diboson	$Z\tau\tau$
Yield	2.5	2.1	3.2
Uncertainty(%)			
Luminosity	± 3.2	± 3.2	± 3.2
JES	+12.8/-8.1	+21.9/-11.7	+23.9/-8.7
JER	± 0.2	± 5.4	± 0.3
JEF	± 2.2	± 1.9	± 5.6
El ID SF	+3.7/-3.7	+3.7/-3.7	+3.8/-3.8
El Trig SF	+0.1/-0.1	+0.1/-0.1	+0.1/-0.1
Mu ID SF	+0.4/-0.4	+0.4/-0.4	+0.4/-0.4
Mu Trig SF	+0.0/-0.0	+0.0/-0.0	+0.0/-0.0
MC x-sec	+10.0/-10.0	+5.0/-5.0	+35.2/-35.2
MC Stat.	± 3.1	± 2.5	± 16.9
Pile-up	± 3.0	± 3.5	± 12.4
El ES	+0.2/-0.2	+0.2/-0.5	+0.0/+0.0
El ER	-0.1/+0.1	+0.1/-0.1	+0.0/+0.0
Mu ES	+0.1/-0.0	+0.1/+0.0	+2.7/+0.0
Mu ER (MS)	+0.1/-0.1	+0.0/-0.0	+0.0/+2.7
Mu ER (ID)	-0.1/+0.1	-0.0/+0.2	+0.0/+0.0
total (syst + lumi)	+17.6/-14.6	+24.0/-15.4	+48.2/-42.6

e μ

Control region plots

- Validation of the distribution (ee channel)



Control region plots

- Validation of the distribution ($\mu\mu$ channel)

